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Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRA	FOF COMMERCE DEMARK OFFICE	ATTY DOCKET NO. 240519US2		SERIAL NO. 10/623,556			
			APPLICANT 10/020,000						
LIST OF	REFE	RENCES CITED BY AF	PLICANT	Kenji SHIRAISHI					
				FILING DATE GROUP					
				July 22, 2003		2622			
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	S SUB FILING DATE IF APPROPRIATE			
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FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		LATION NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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	AZ				Additional References sheet(s) attached				
Examiner	/Nhan Tran/					Date Considered 09/25/2007			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									